Test Report issued under the responsibility of:





TEST REPORT			
IEC 60947-2 Low-voltage switchgear and controlgear - Part 2: Circuit-breakers			
Report Reference No	CB201700C-075339		
Date of issue:	20 25		
Total number of pages			
CB Testing Laboratory:	Shanghal resting & Inspection Institute for Electrical Equipment (STIEE)		
Address:	505 Wu Ning Rd. Shanghai 200063, P.R. CHINA		
Applicant's name:	ZhejiangTENGEN Electrics Co., Ltd.		
Address:	Sulv Industry Zone, Liushi, Yueqing, Zhejiang, P.R. China		
Test specification:			
Standard:	IEC 60947-2:2006 (Fourth Edition) + A1: 2009 + A2: 2013		
Test procedure:	CB scheme		
Non-standard test method	N/A		
Test Report Form No	IEC60947_2G		
Test Report Form(s) Originator:	DEKRA Certification BV		
Master TRF:	Dated 2013-11		
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Test item description:	Moulded Case Circuit Breaker DC		
Trade Mark:	TENGEN		
Manufacturer:	ZhejiangTENGEN Electrics Co., Ltd.		
	Sulv Industry Zone,Liushi,Yueqing,Zhejiang,P.R.China		
Model/Type reference:	TGM3DC-250M		
Ratings:	Ue: DC250V/500V/750V/1000V; In: 100A,125A,140A,160A,180A,200A,225A,250A;		

Testing procedure and testing location:		
CB Testing Laboratory:	Shanghai Testing & Inspection Equipment (STIEE)	Institute for Electrical
Testing location/ address	505 Wu Ning Rd. Shanghai 200063, P.R. CHINA	
Tested by (name + signature)	Cui Tao/ Engineer	在·游 魏沃媛
Approved by (name + signature)	WeiQingYuan/SeniorEngineer	魏沃媛
Testing procedure: TMP	N/A	
Testing location/ address	: N/A	
Tested by (name + signature)	N/A	
Approved by (name + signature)	N/A	
Testing procedure: WMT	N/A	
Testing location/ address	N/A	
Tested by (name + signature)	N/A	
Witnessed by (name + signature)	N/A	
Approved by (name + signature)	N/A	
	1	
Testing procedure: SMT	N/A	
Testing location/ address	: N/A	
Tested by (name + signature)	N/A	
Approved by (name + signature)	N/A	
Supervised by (name + signature)	N/A	

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